Search Notes

Application/Control	No.

Applicant(s)/Patent under Reexamination
MURAYAMA ET AL.

10/748,158

Examiner

2826

Art Unit

Tuan Quach

SEARCHED				
Class	Subclass	Date	Examiner	
257	197, 198, 201, 565	1/29/2005	TQ	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
257	197-201	1/31/2005	TQ	
257	565	1/31/2005	TQ	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST (USPAT; USPGPUB; EPO; JPO; DERWENT; IBMTDB)	1/29/2005	TQ
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